Search Notes



| App | lica | tion/ | Contr | ol No |
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Applicant(s)/Patent Under Reexamination

MEYER ET AL.

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Art Unit

3621

JACOB C. COPPOLA

SEARCHED

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SEARCH NOTES

| Search Notes | Date | Examiner |
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| Text search in Google Patents | 2/9/2010 | /J.C.C./ |
| Text search in EAST (see attached history) | 2/9/2010 | /J.C.C./ |
| STIC (EIC-3600) search for allowance in class 705 (see attached) | 6/25/2010 | /J.C.C./ |

INTERFERENCE SEARCH

| Class | Subclass | Date | Examiner |
|-------|----------|----------|----------|
| 705 | 50-79 | 7/7/2010 | /J.C.C./ |

/JACOB C. COPPOLA/ Examiner, Art Unit 3621

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